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(12) **United States Design Patent**  
**Man**

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(54) **RFID TAG INLAY**

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(\*\*) Term: **14 Years**

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(52) **U.S. Cl.**  
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(58) **Field of Classification Search**  
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See application file for complete search history.

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*Primary Examiner* — John Windmuller

(57) **CLAIM**

The ornamental design for an RFID tag inlay, as shown and described.

**DESCRIPTION**

The sole FIGURE is a top plan view of an RFID tag inlay showing my new design.

The solid black areas constitute the entirety of the claimed design. All elements of the claimed design are flat and coplanar.

**1 Claim, 1 Drawing Sheet**



